

# IRF9910PbF

HEXFET® Power MOSFET

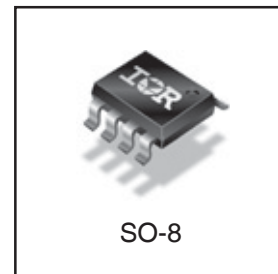
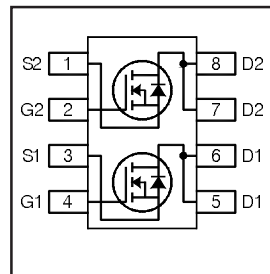
## Applications

- Dual SO-8 MOSFET for POL converters in desktop, servers, graphics cards, game consoles and set-top box
- Lead-Free

## Benefits

- Very Low  $R_{DS(on)}$  at 4.5V  $V_{GS}$
- Low Gate Charge
- Fully Characterized Avalanche Voltage and Current
- 20V  $V_{GS}$  Max. Gate Rating

| $V_{DSS}$ | $R_{DS(on)}$ max                   | $I_D$ |
|-----------|------------------------------------|-------|
| 20V       | Q1 13.4m $\Omega$ @ $V_{GS} = 10V$ | 10A   |
|           | Q2 9.3m $\Omega$ @ $V_{GS} = 10V$  | 12A   |



## Absolute Maximum Ratings

|                                        | Parameter                                       | Q1 Max.      | Q2 Max. | Units |
|----------------------------------------|-------------------------------------------------|--------------|---------|-------|
| V <sub>DS</sub>                        | Drain-to-Source Voltage                         | 20           |         | V     |
| V <sub>GS</sub>                        | Gate-to-Source Voltage                          | ± 20         |         |       |
| I <sub>D</sub> @ T <sub>A</sub> = 25°C | Continuous Drain Current, V <sub>GS</sub> @ 10V | 10           | 12      | A     |
| I <sub>D</sub> @ T <sub>A</sub> = 70°C | Continuous Drain Current, V <sub>GS</sub> @ 10V | 8.3          | 9.9     |       |
| I <sub>DM</sub>                        | Pulsed Drain Current ①                          | 83           | 98      |       |
| P <sub>D</sub> @T <sub>A</sub> = 25°C  | Power Dissipation                               | 2.0          |         | W     |
| P <sub>D</sub> @T <sub>A</sub> = 70°C  | Power Dissipation                               | 1.3          |         |       |
|                                        | Linear Derating Factor                          | 0.016        |         | W/°C  |
| T <sub>J</sub>                         | Operating Junction and                          | -55 to + 150 |         | °C    |
| T <sub>STG</sub>                       | Storage Temperature Range                       |              |         |       |

## Thermal Resistance

|                 | Parameter              | Typ. | Max. | Units        |
|-----------------|------------------------|------|------|--------------|
| $R_{\theta JL}$ | Junction-to-Drain Lead | —    | 42   | $^\circ C/W$ |
| $R_{\theta JA}$ | Junction-to-Ambient ④⑤ | —    | 62.5 |              |

Notes ① through ⑤ are on page 10

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# IRF9910PbF

International  
**IR** Rectifier

Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

|                                | Parameter                                  |       | Min. | Typ.   | Max. | Units                | Conditions                                                                                                                               |
|--------------------------------|--------------------------------------------|-------|------|--------|------|----------------------|------------------------------------------------------------------------------------------------------------------------------------------|
| $BV_{DSS}$                     | Drain-to-Source Breakdown Voltage          | Q1&Q2 | 20   | —      | —    | V                    | $V_{GS} = 0V, I_D = 250\mu A$                                                                                                            |
| $\Delta BV_{DSS}/\Delta T_J$   | Breakdown Voltage Temp. Coefficient        | Q1    | —    | 0.0061 | —    | V/ $^\circ\text{C}$  | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$                                                                                     |
|                                |                                            | Q2    | —    | 0.014  | —    |                      |                                                                                                                                          |
| $R_{DS(on)}$                   | Static Drain-to-Source On-Resistance       | Q1    | —    | 10.7   | 13.4 | $m\Omega$            | $V_{GS} = 10V, I_D = 10A$ ①                                                                                                              |
|                                |                                            |       | —    | 14.6   | 18.3 |                      | $V_{GS} = 4.5V, I_D = 8.3A$ ③                                                                                                            |
|                                |                                            | Q2    | —    | 7.4    | 9.3  |                      | $V_{GS} = 10V, I_D = 12A$ ③                                                                                                              |
|                                |                                            |       | —    | 9.1    | 11.3 |                      | $V_{GS} = 4.5V, I_D = 9.8A$ ③                                                                                                            |
| $V_{GS(th)}$                   | Gate Threshold Voltage                     | Q1&Q2 | 1.65 | —      | 2.55 | V                    | $V_{DS} = V_{GS}, I_D = 250\mu A$                                                                                                        |
| $\Delta V_{GS(th)}/\Delta T_J$ | Gate Threshold Voltage Coefficient         | Q1    | —    | -4.9   | —    | mV/ $^\circ\text{C}$ |                                                                                                                                          |
|                                |                                            | Q2    | —    | -5.0   | —    |                      |                                                                                                                                          |
| $I_{DSS}$                      | Drain-to-Source Leakage Current            | Q1&Q2 | —    | —      | 1.0  | $\mu A$              | $V_{DS} = 16V, V_{GS} = 0V$                                                                                                              |
|                                |                                            | Q1&Q2 | —    | —      | 100  |                      | $V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$                                                                                     |
| $I_{GSS}$                      | Gate-to-Source Forward Leakage             | Q1&Q2 | —    | —      | 100  | nA                   | $V_{GS} = 20V$                                                                                                                           |
|                                | Gate-to-Source Reverse Leakage             | Q1&Q2 | —    | —      | -100 |                      | $V_{GS} = -20V$                                                                                                                          |
| $g_{fs}$                       | Forward Transconductance                   | Q1    | 19   | —      | —    | S                    | $V_{DS} = 10V, I_D = 8.3A$                                                                                                               |
|                                |                                            | Q2    | 27   | —      | —    |                      | $V_{DS} = 10V, I_D = 9.8A$                                                                                                               |
| $Q_g$                          | Total Gate Charge                          | Q1    | —    | 7.4    | 11   | nC                   | Q1<br>$V_{DS} = 10V$<br>$V_{GS} = 4.5V, I_D = 8.3A$<br><br>Q2<br>$V_{DS} = 10V$<br>$V_{GS} = 4.5V, I_D = 9.8A$                           |
|                                |                                            | Q2    | —    | 15     | 23   |                      |                                                                                                                                          |
| $Q_{GS1}$                      | Pre-V <sub>th</sub> Gate-to-Source Charge  | Q1    | —    | 2.6    | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 4.3    | —    |                      |                                                                                                                                          |
| $Q_{GS2}$                      | Post-V <sub>th</sub> Gate-to-Source Charge | Q1    | —    | 0.85   | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 1.4    | —    |                      |                                                                                                                                          |
| $Q_{gd}$                       | Gate-to-Drain Charge                       | Q1    | —    | 2.5    | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 5.4    | —    |                      |                                                                                                                                          |
| $Q_{godr}$                     | Gate Charge Overdrive                      | Q1    | —    | 1.5    | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 3.9    | —    |                      |                                                                                                                                          |
| $Q_{sw}$                       | Switch Charge ( $Q_{GS2} + Q_{gd}$ )       | Q1    | —    | 3.4    | —    | nC                   | $V_{DS} = 10V, V_{GS} = 0V$                                                                                                              |
|                                |                                            | Q2    | —    | 6.8    | —    |                      |                                                                                                                                          |
| $Q_{oss}$                      | Output Charge                              | Q1    | —    | 4.0    | —    | nC                   | $V_{DS} = 10V, V_{GS} = 0V$                                                                                                              |
|                                |                                            | Q2    | —    | 8.7    | —    |                      |                                                                                                                                          |
| $t_{d(on)}$                    | Turn-On Delay Time                         | Q1    | —    | 6.3    | —    | ns                   | Q1<br>$V_{DD} = 16V, V_{GS} = 4.5V$<br>$I_D = 8.3A$<br><br>Q2<br>$V_{DD} = 16V, V_{GS} = 4.5V$<br>$I_D = 9.8A$<br>Clamped Inductive Load |
|                                |                                            | Q2    | —    | 8.3    | —    |                      |                                                                                                                                          |
| $t_r$                          | Rise Time                                  | Q1    | —    | 10     | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 14     | —    |                      |                                                                                                                                          |
| $t_{d(off)}$                   | Turn-Off Delay Time                        | Q1    | —    | 9.2    | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 15     | —    |                      |                                                                                                                                          |
| $t_f$                          | Fall Time                                  | Q1    | —    | 4.5    | —    | pF                   | $V_{GS} = 0V$<br>$V_{DS} = 10V$<br>$f = 1.0\text{MHz}$                                                                                   |
|                                |                                            | Q2    | —    | 7.5    | —    |                      |                                                                                                                                          |
| $C_{iss}$                      | Input Capacitance                          | Q1    | —    | 900    | —    |                      |                                                                                                                                          |
|                                |                                            | Q2    | —    | 1860   | —    |                      |                                                                                                                                          |
| $C_{oss}$                      | Output Capacitance                         | Q1    | —    | 290    | —    | pF                   | $V_{GS} = 0V$<br>$V_{DS} = 10V$<br>$f = 1.0\text{MHz}$                                                                                   |
|                                |                                            | Q2    | —    | 600    | —    |                      |                                                                                                                                          |
| $C_{rss}$                      | Reverse Transfer Capacitance               | Q1    | —    | 140    | —    | pF                   | $V_{GS} = 0V$<br>$V_{DS} = 10V$<br>$f = 1.0\text{MHz}$                                                                                   |
|                                |                                            | Q2    | —    | 310    | —    |                      |                                                                                                                                          |

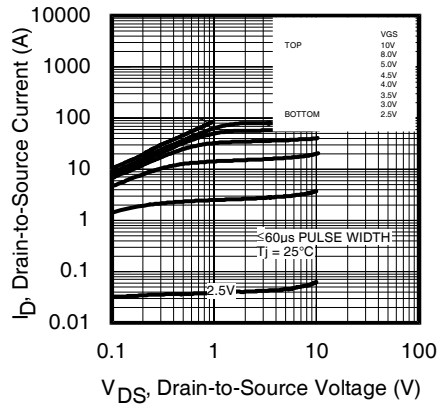
## Avalanche Characteristics

|          | Parameter                       | Typ. | Q1 Max. | Q2 Max. | Units |
|----------|---------------------------------|------|---------|---------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy ② | —    | 33      | 26      | mJ    |
| $I_{AR}$ | Avalanche Current ①             | —    | 8.3     | 9.8     | A     |

## Diode Characteristics

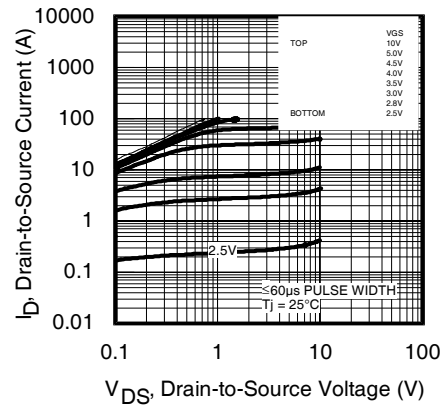
|          | Parameter                              |       | Min. | Typ. | Max. | Units | Conditions                                                                            |
|----------|----------------------------------------|-------|------|------|------|-------|---------------------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | Q1&Q2 | —    | —    | 2.5  | A     | MOSFET symbol showing the integral reverse p-n junction diode.                        |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | Q1    | —    | —    | 83   | A     |  |
|          |                                        | Q2    | —    | —    | 98   |       |                                                                                       |
| $V_{SD}$ | Diode Forward Voltage                  | Q1    | —    | —    | 1.0  | V     | $T_J = 25^\circ\text{C}, I_S = 8.3A, V_{GS} = 0V$ ③                                   |
|          |                                        | Q2    | —    | —    | 1.0  |       | $T_J = 25^\circ\text{C}, I_S = 9.8A, V_{GS} = 0V$ ③                                   |
| $t_{rr}$ | Reverse Recovery Time                  | Q1    | —    | 11   | 17   | ns    | Q1 $T_J = 25^\circ\text{C}, I_F = 8.3A, V_{DD} = 10V, di/dt = 100A/\mu s$ ③           |
|          |                                        | Q2    | —    | 16   | 24   |       | Q2 $T_J = 25^\circ\text{C}, I_F = 9.8A, V_{DD} = 10V, di/dt = 100A/\mu s$ ③           |
| $Q_{rr}$ | Reverse Recovery Charge                | Q1    | —    | 3.1  | 4.7  | nC    |                                                                                       |
|          |                                        | Q2    | —    | 4.9  | 7.3  |       |                                                                                       |

**Q1 - Control FET**

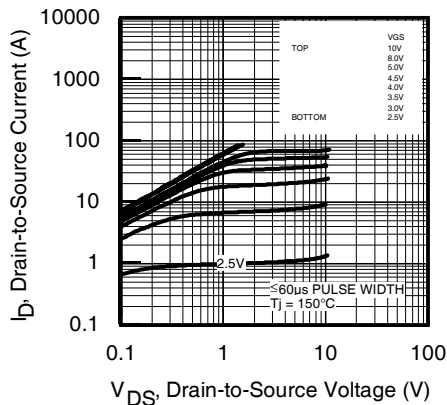


**Fig 1.** Typical Output Characteristics

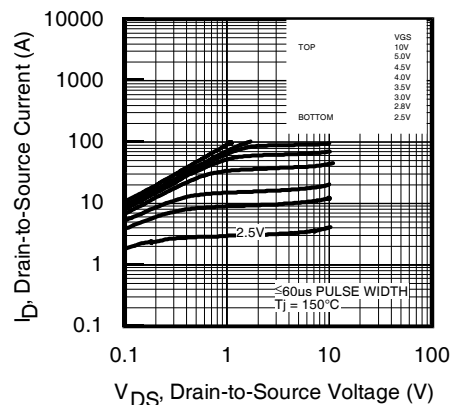
**Q2 - Synchronous FET**



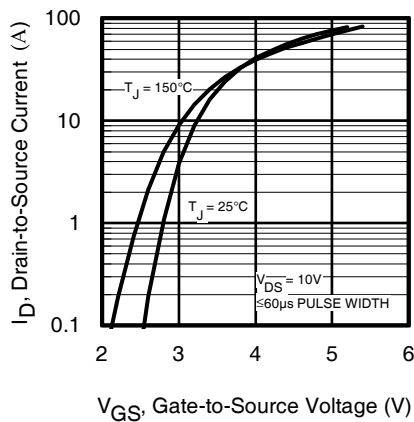
**Fig 2.** Typical Output Characteristics



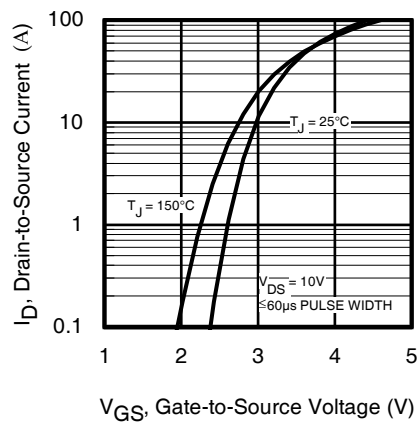
**Fig 3.** Typical Output Characteristics



**Fig 4.** Typical Output Characteristics



**Fig 5.** Typical Transfer Characteristics



**Fig 6.** Typical Transfer Characteristics

# IRF9910PbF

## Typical Characteristics

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### Q1 - Control FET

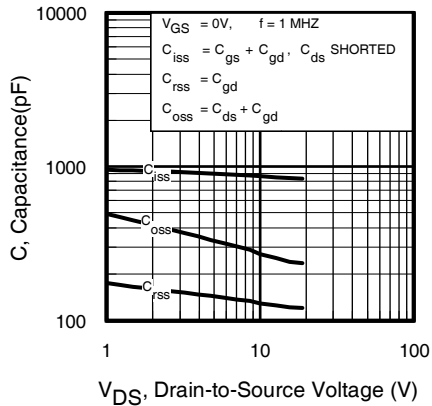


Fig 7. Typical Capacitance Vs. Drain-to-Source Voltage

### Q2 - Synchronous FET

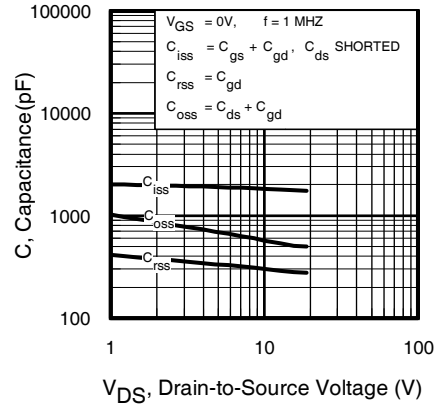


Fig 8. Typical Capacitance Vs. Drain-to-Source Voltage

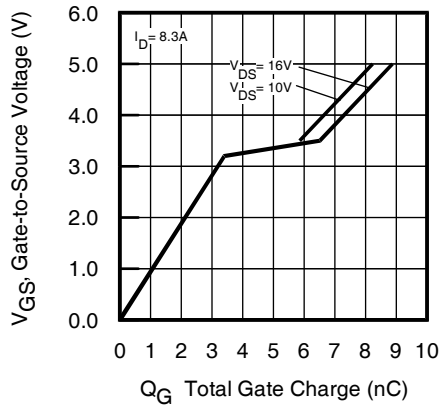


Fig 9. Gate-to-Source Voltage vs Typical Gate Charge

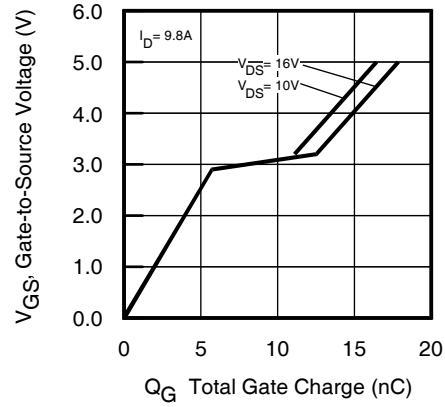


Fig 10. Gate-to-Source Voltage vs Typical Gate Charge

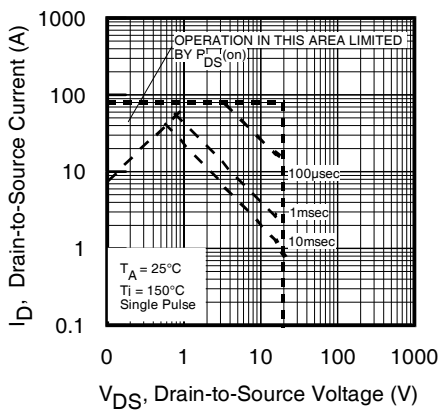


Fig 11. Maximum Safe Operating Area

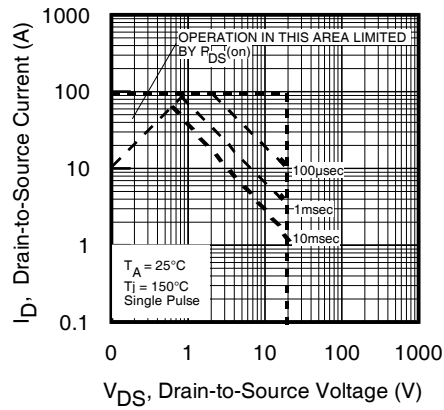
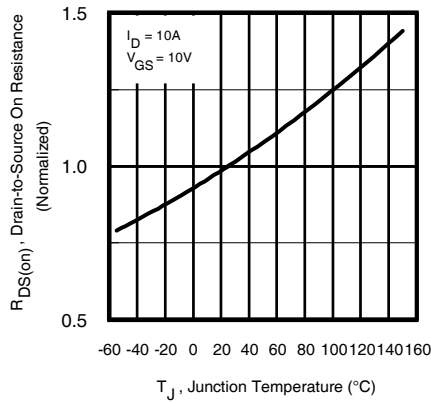


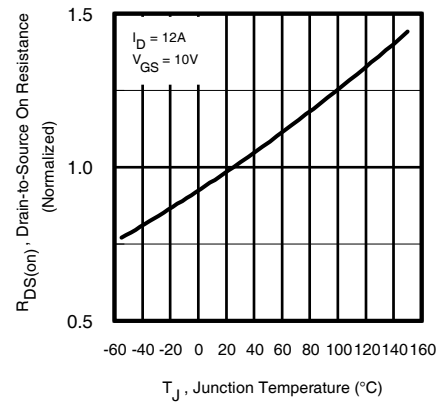
Fig 12. Maximum Safe Operating Area

**Q1 - Control FET**

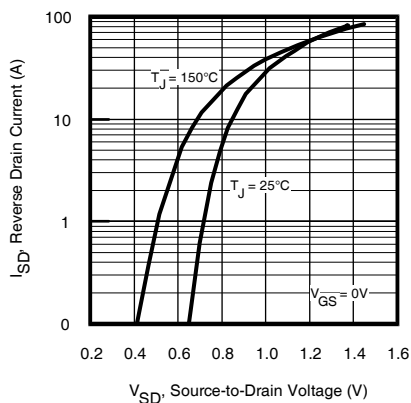


**Fig 13.** Normalized On-Resistance vs. Temperature

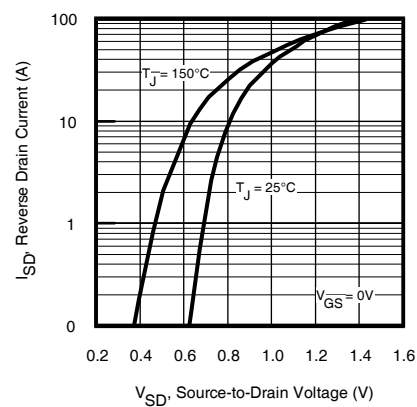
**Q2 - Synchronous FET**



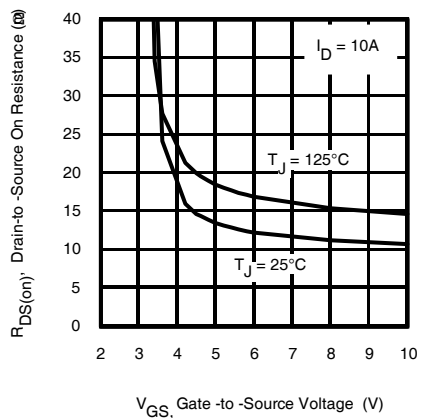
**Fig 14.** Normalized On-Resistance vs. Temperature



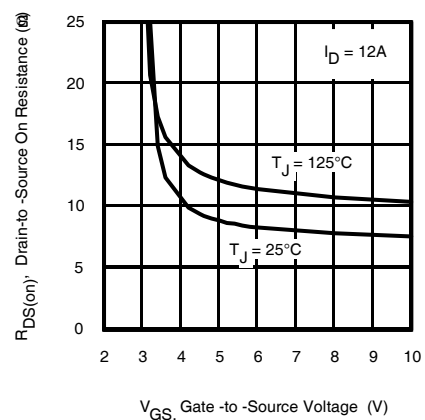
**Fig 15.** Typical Source-Drain Diode Forward Voltage



**Fig 16.** Typical Source-Drain Diode Forward Voltage

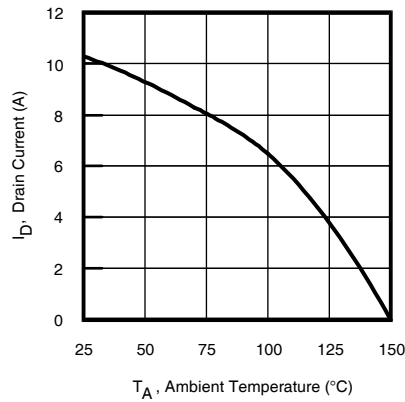


**Fig 17.** Typical On-Resistance vs. Gate Voltage



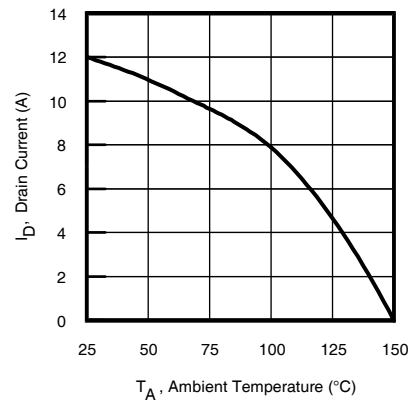
**Fig 18.** Typical On-Resistance vs. Gate Voltage

**Q1 - Control FET**

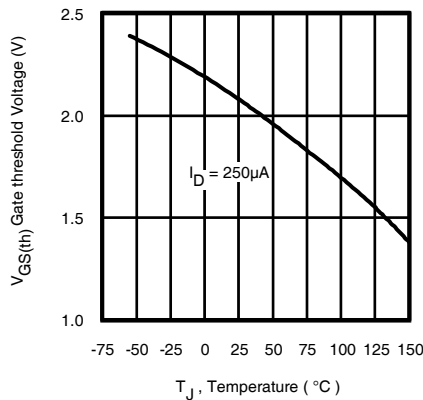


**Fig 19.** Maximum Drain Current vs. Ambient Temperature

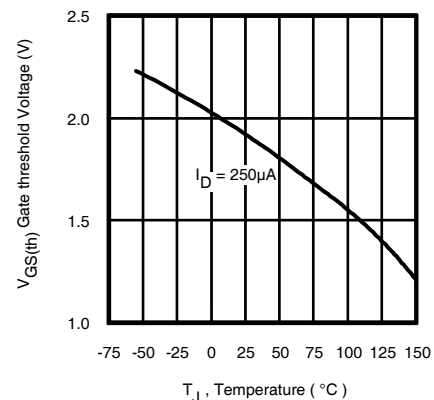
**Q2 - Synchronous FET**



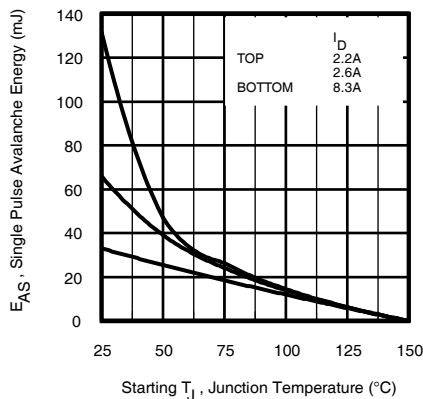
**Fig 20.** Maximum Drain Current vs. Ambient Temperature



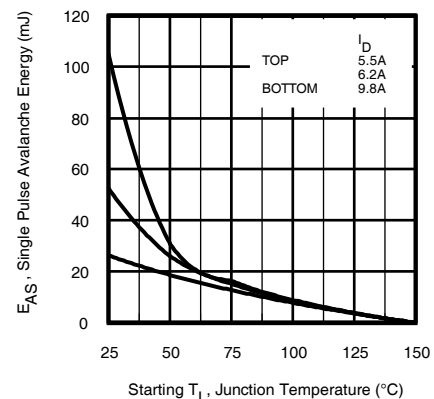
**Fig 21.** Threshold Voltage vs. Temperature



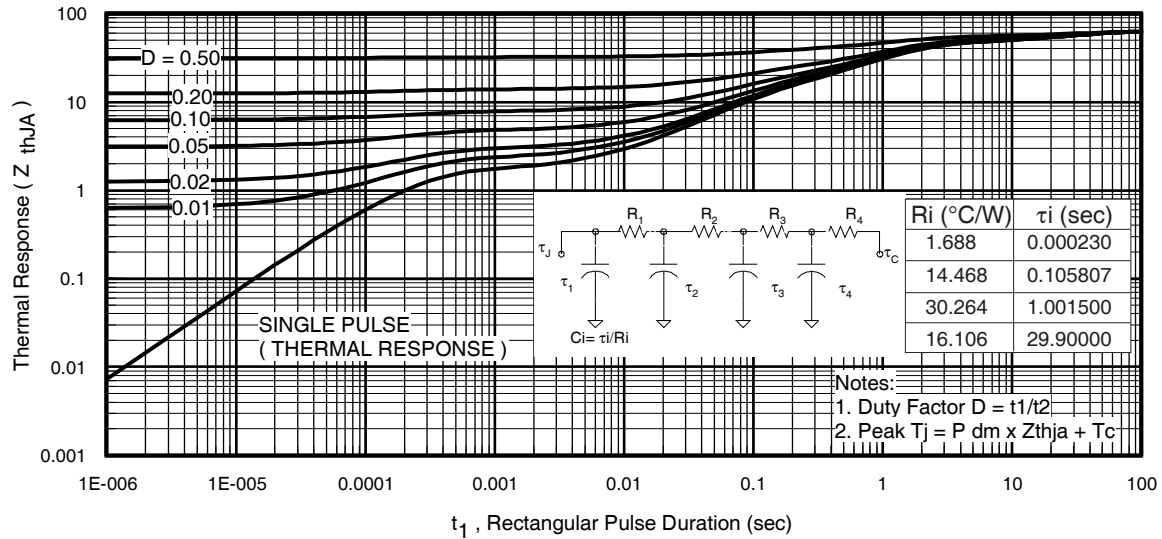
**Fig 22.** Threshold Voltage vs. Temperature



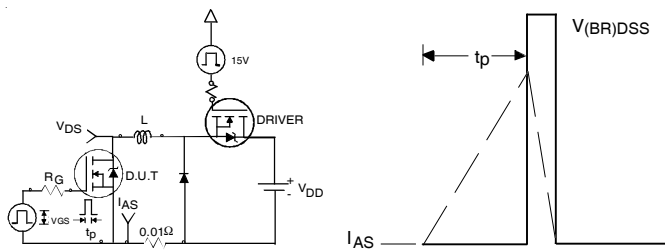
**Fig 23.** Maximum Avalanche Energy vs. Drain Current



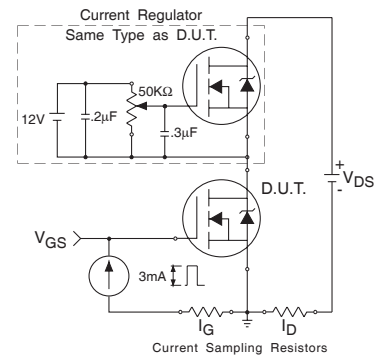
**Fig 24.** Maximum Avalanche Energy vs. Drain Current



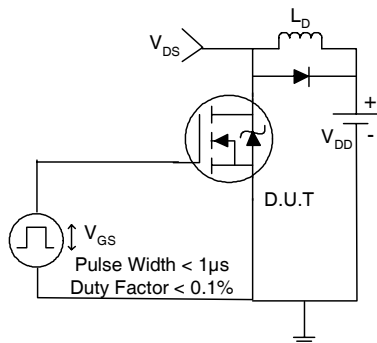
**Fig 25.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



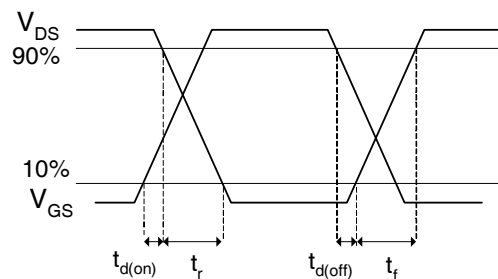
**Fig 26.** Unclamped Inductive Test Circuit and Waveform



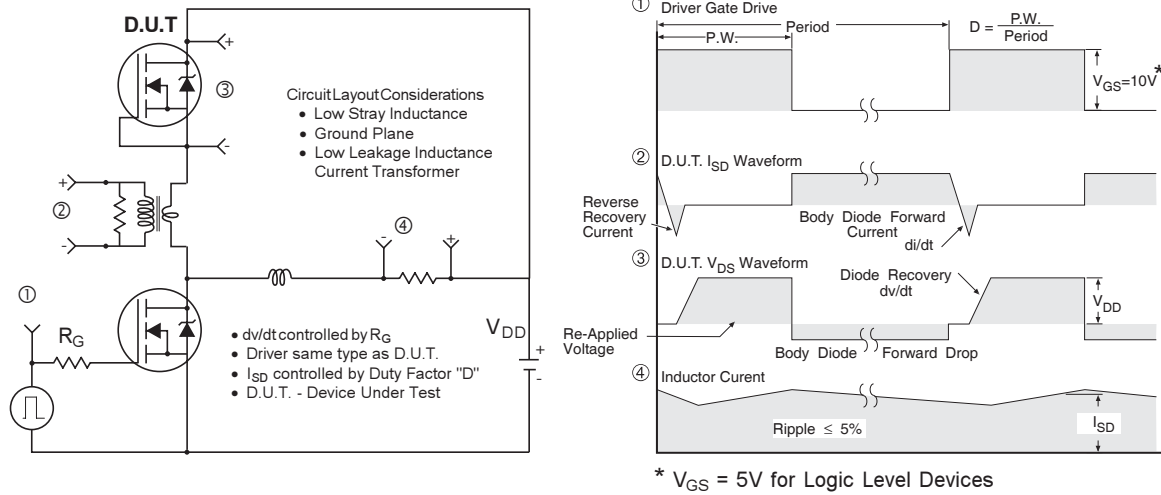
**Fig 27.** Gate Charge Test Circuit



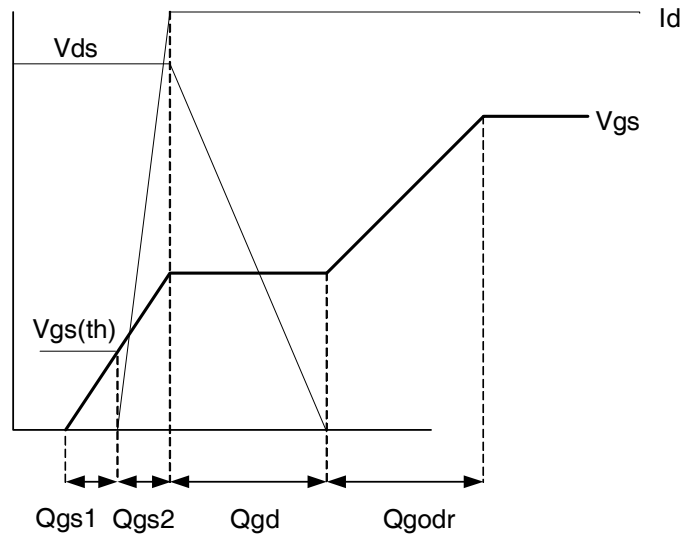
**Fig 28.** Switching Time Test Circuit



**Fig 29.** Switching Time Waveforms



**Fig 30. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs**

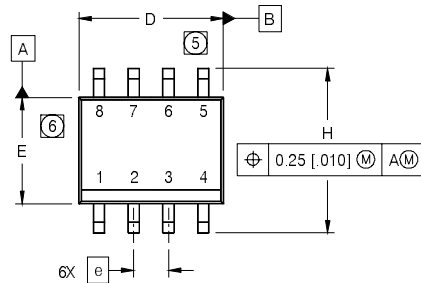


**Fig 31. Gate Charge Waveform**

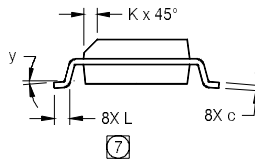
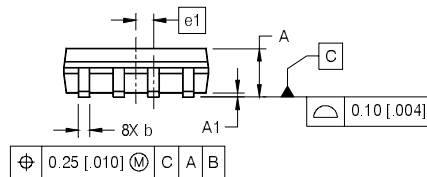


## SO-8 Package Outline (Mosfet & Fetky)

Dimensions are shown in millimeters (inches)



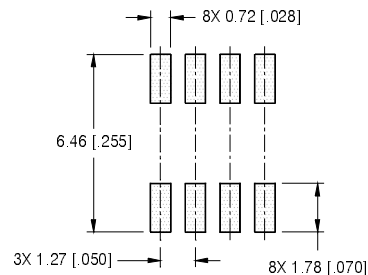
| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e1  | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |



### NOTES:

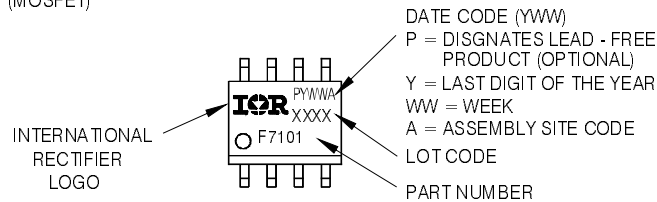
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

### FOOTPRINT



## SO-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7101 (MOSFET)



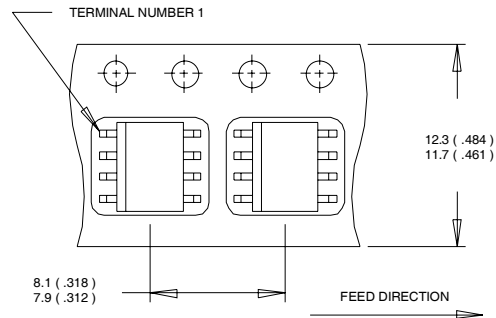
Note: For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

# IRF9910PbF

## SO-8 Tape and Reel

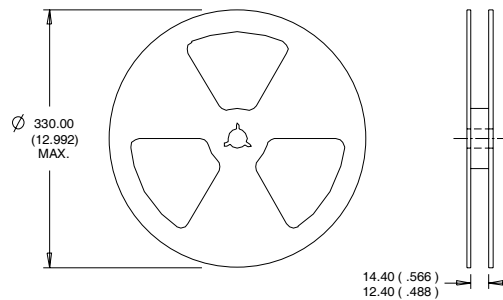
Dimensions are shown in millimeters (inches)

International  
**IR** Rectifier



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



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**Note:** For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ , Q1:  $L = 0.95\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 8.3\text{A}$ ; Q2:  $L = 0.54\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 9.8\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board.
- ⑤  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualifications Standards can be found on IR's Web site.

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